

N-Channel 100-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|----------------------------|------------------------|-------|--|--|--|--|
| V _{DS} (V) | 100 | | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V | 0.086 | | | | |
| Q _g (Max.) (nC) | 72 | | | | | |
| Q _{gs} (nC) | 11 | | | | | |
| Q _{gd} (nC) | 32 | | | | | |
| Configuration | Single | | | | | |

FEATURES

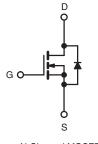
- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available



RoHS COMPLIANT



TO-220 FULLPAK



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS T | c = 25 °C, ur | nless otherw | ise noted | | | |
|--|-------------------------|-----------------------------------|-----------------|------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 100 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | I _D | 18 | | |
| | VGS at 10 V | T _C = 100 °C | | 12 | A | |
| Pulsed Drain Current ^a | | | I _{DM} | 68 | 1 | |
| Linear Derating Factor | | | | 0.32 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 720 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 17 | A | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 4.8 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | PD | 48 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 5.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to + 175 | °C | | |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300 ^d | 1 | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| | | | | 1.1 | N ⋅ m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 3.7 mH, $R_G = 25 \Omega$, $I_{AS} = 17 \text{ A}$ (see fig. 12). c. $I_{SD} \le 17 \text{ A}$, dl/dt $\le 200 \text{ A}/\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.



| THERMAL RESISTANCE RAT | TINGS | | | | | | | |
|--|---|--|--|--|------|-------|-------|------|
| PARAMETER | SYMBOL | TYP. MAX. | | | | UNIT | | |
| Maximum Junction-to-Ambient | R _{thJA} | - 65 | | | 2011 | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 3.1 | | | | °C/W | | |
| | | | | | | | | |
| SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, | unless otherv | vise noted | | | | | | |
| PARAMETER | SYMBOL | TES | T CONDITI | ONS | MIN. | TYP. | MAX. | UNI |
| Static | | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = 2 | 50 µA | 100 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, | I _D = 1 mA | - | 0.13 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 2 | 250 μΑ | 1.0 | - | 3.0 | V |
| Gate-Source Leakage | I _{GSS} | | $V_{GS} = \pm 20$ | V | - | - | ± 100 | nA |
| Zara Cata Valtaga Drain Current | | V _{DS} = 100 V, V _{GS} = 0 V | s = 0 V | - | - | 25 | | |
| zero Gale voltage Drain Current | Zero Gate Voltage Drain Current I _{DSS} V _{DS} = 80 | V _{DS} = 80 V | , V _{GS} = 0 V, | T _J = 150 °C | - | - | 250 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D | = 10 A ^b | - | 0.086 | - | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} : | = 50 V, I _D = | 10 A ^b | 9.1 | - | - | S |
| Dynamic | | | | | • | • | | |
| Input Capacitance | C _{iss} | $V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5 f = 1.0 MHz | | - | 1700 | - | pF | |
| Output Capacitance | C _{oss} | | | - | 560 | - | | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 120 | - | | |
| Drain to Sink Capacitance | С | | | - | 12 | - | | |
| Total Gate Charge | Qg | | | | - | - | 72 | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | | l _D = 17 A, V _{DS} = 80 V, see fig. 6 and 13 ^b | - | - | 11 | nC |
| Gate-Drain Charge | Q _{gd} | | 300 H | | - | - | 32 | |
| Turn-On Delay Time | t _{d(on)} | | • | | - | 11 | - | |
| Rise Time | t _r | $\label{eq:V_DD} \begin{array}{l} {\sf V}_{DD} = 50 \; {\sf V}, \; {\sf I}_D = 17 \; {\sf A}, \\ {\sf R}_{\sf G} = 9.1 \; \Omega, \; {\sf R}_{\sf D} \!$ | | - | 44 | - | - ns | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 53 | - | | |
| Fall Time | t _f | | | - | 43 | - | | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | nH | |
| Internal Source Inductance | L _S | | | - | 7.5 | - | | |
| Drain-Source Body Diode Characteristic | s | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the | | - | - | 17 | A | |
| Pulsed Diode Forward Current ^a | I _{SM} | p - n junction diode | | | - | - | | 68 |
| Body Diode Voltage | V_{SD} | $T_J = 25 \ ^{\circ}C, \ I_S = 17 \ A, \ V_{GS} = 0 \ V^b$ | | | - | - | 2.5 | V |
| Body Diode Reverse Recovery Time | t _{rr} | $T_J = 25 \text{ °C}, I_F = 17 \text{ A}, dI/dt = 100 \text{ A}/\mu s^b$ | | - | 180 | 360 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 1.3 | 2.6 | μC | |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





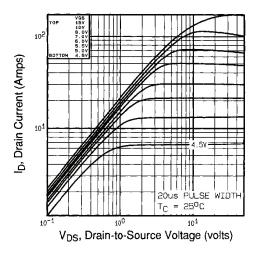


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

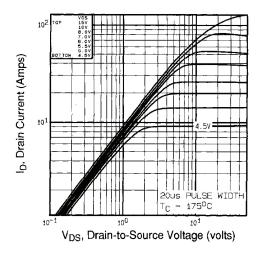


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

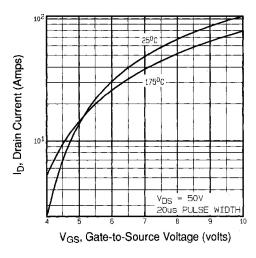


Fig. 3 - Typical Transfer Characteristics

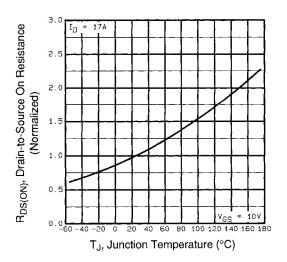


Fig. 4 - Normalized On-Resistance vs. Temperature

IRLI520NPBF

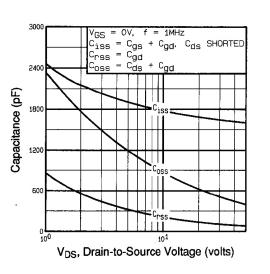
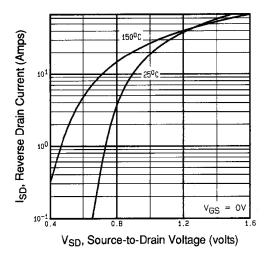


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



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Fig. 7 - Typical Source-Drain Diode Forward Voltage

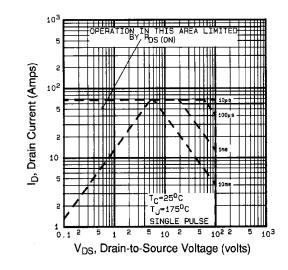


Fig. 8 - Maximum Safe Operating Area

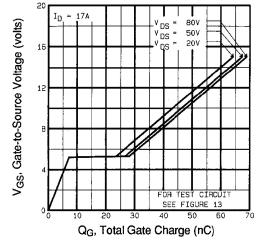


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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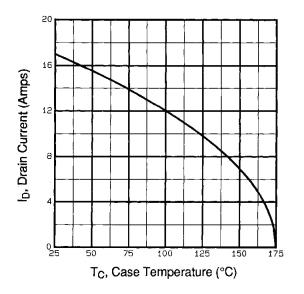


Fig. 9 - Maximum Drain Current vs. Case Temperature

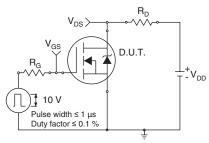


Fig. 10a - Switching Time Test Circuit

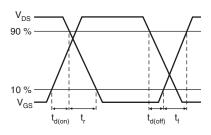
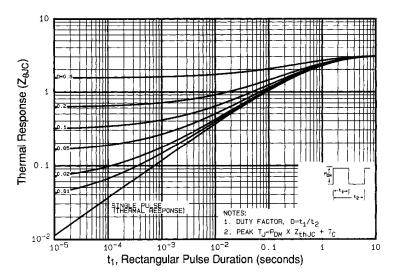


Fig. 10b - Switching Time Waveforms





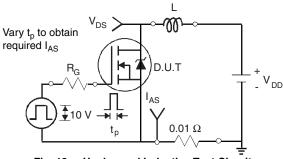


Fig. 12a - Unclamped Inductive Test Circuit

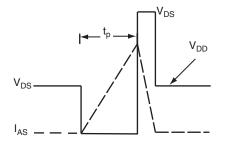


Fig. 12b - Unclamped Inductive Waveforms



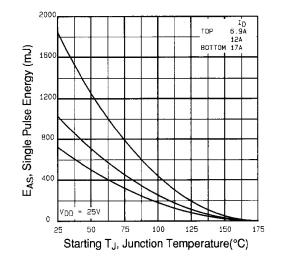


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

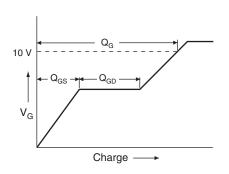
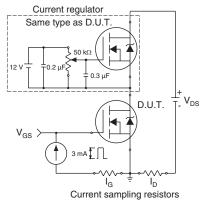
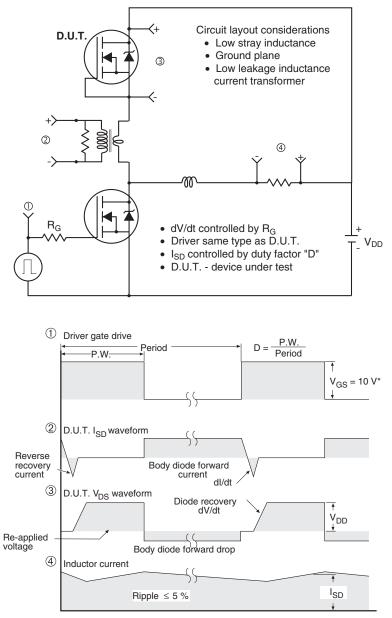


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig.14 - For N-Channel



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